Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/771,062	WISE ET AL.	
Examiner	Art Unit	
Dustin Nguyen	2154	

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Class	Subclass	Date	Examiner
714	30	8/23/2005	DN
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
searches EAST	8/23/2005	DN	